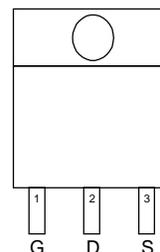


N-Channel Enhancement Mode MOSFET

Features

- 30V / 80A , $R_{DS(ON)} = 4m\Omega(\text{typ.}) @ V_{GS} = 10V$
 $R_{DS(ON)} = 7m\Omega(\text{typ.}) @ V_{GS} = 4.5V$
- Super High Dense Advanced Cell Design for Extremely Low $R_{DS(ON)}$
- Reliable and Rugged
- TO-220, TO-252 and TO-263 Packages

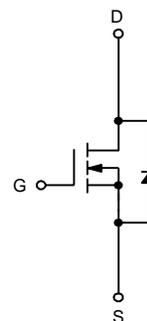
Pin Description



Top View of TO-220, TO-252 and TO-263

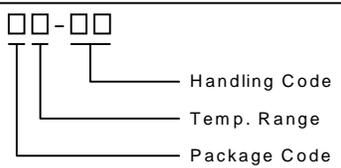
Applications

- Power Management in Desktop Computer or DC/DC Converters.



N-Channel MOSFET

Ordering and Marking Information

<p>APM3005N □□-□□</p>  <p style="margin-left: 150px;"> Handling Code Temp. Range Package Code </p>	<p>Package Code F : TO-220 U : TO-252 G : TO-263 Operating Junction Temp. Range C : -55 to 125 °C Handling Code TU : Tube TR : Tape & Reel</p>
<p>APM3005N : </p>	<p>XXXXX - Date Code</p>

Absolute Maximum Ratings ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Rating	Unit
V_{DSS}	Drain-Source Voltage	30	V
V_{GSS}	Gate-Source Voltage	± 20	
I_D^*	Maximum Drain Current – Continuous	80	A
I_{DM}	Maximum Drain Current – Pulsed	160	

ANPEC reserves the right to make changes to improve reliability or manufacturability without notice, and advise customers to obtain the latest version of relevant information to verify before placing orders.

Absolute Maximum Ratings (Cont.) ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Rating	Unit		
P_D	Maximum Power Dissipation	$T_A=25^\circ\text{C}$	TO-252	50	W
			TO-263	62.5	
		$T_A=100^\circ\text{C}$	TO-252	20	W
			TO-263	25	
T_J, T_{STG}	Maximum Operating and Storage Junction Temperature	-55 to 150	$^\circ\text{C}$		
$R_{\theta JA}$	Thermal Resistance – Junction to Ambient	TO-252	50	$^\circ\text{C/W}$	
		TO-263	60		
$R_{\theta JC}$	Thermal Resistance – Junction to Case	TO-252	2.5	$^\circ\text{C/W}$	
		TO-263	2		

* Surface Mounted on FR4 Board, $t \leq 10$ sec.

Electrical Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise noted)

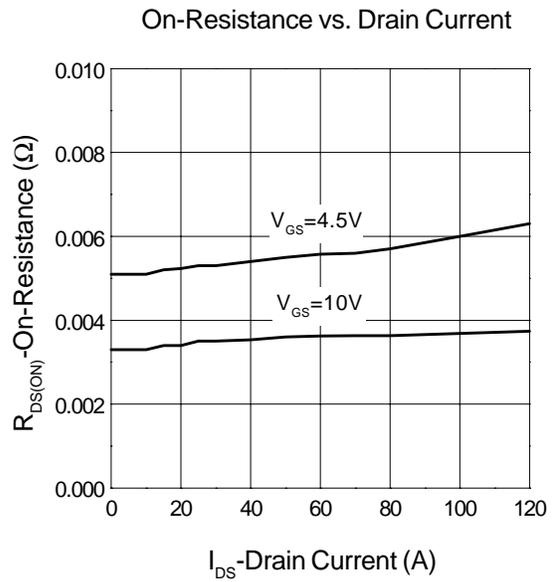
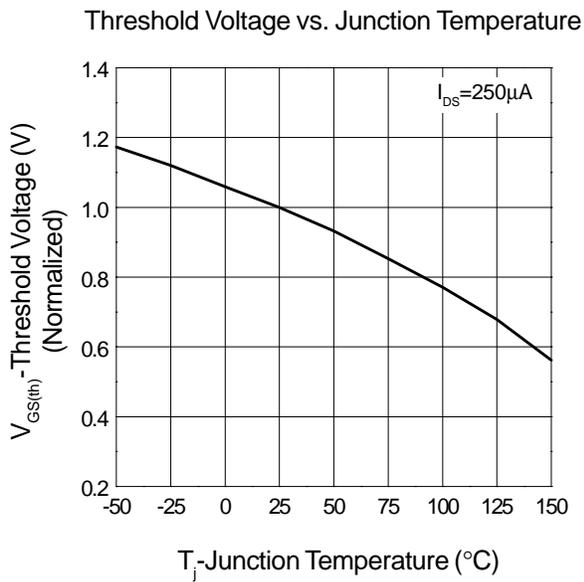
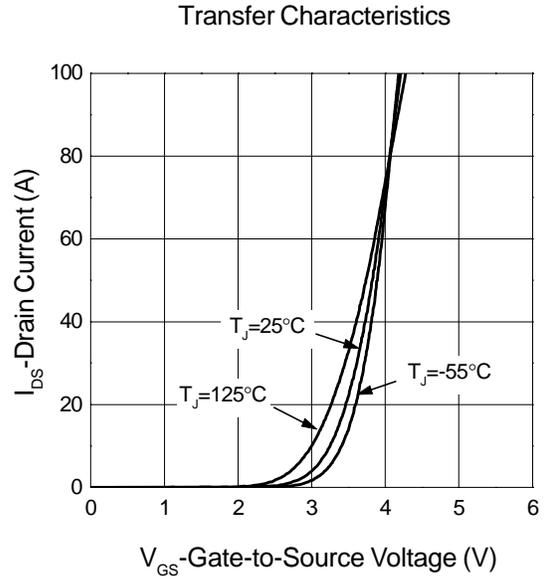
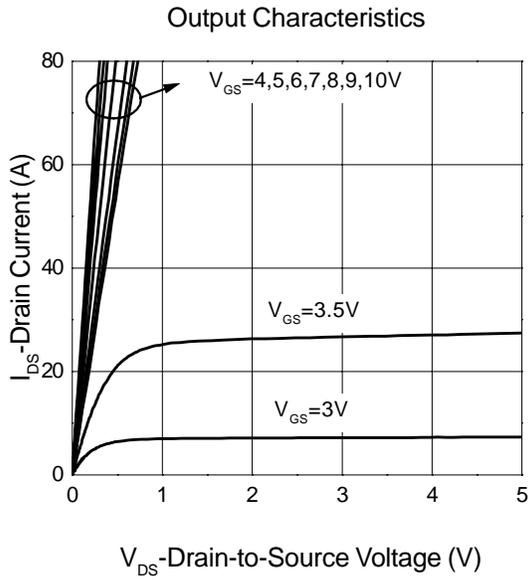
Symbol	Parameter	Test Condition	APM3005N			Unit
			Min.	Typ.	Max.	
Static						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_{DS}=250\mu\text{A}$	30			V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=24V, V_{GS}=0V$			1	μA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_{DS}=250\mu\text{A}$	1	1.5	2	V
I_{GSS}	Gate Leakage Current	$V_{GS}=\pm 20V, V_{DS}=0V$			± 100	nA
$R_{DS(ON)}^a$	Drain-Source On-state Resistance	$V_{GS}=10V, I_{DS}=80A$		4	5.4	m Ω
		$V_{GS}=4.5V, I_{DS}=70A$		7	8	
V_{SD}^a	Diode Forward Voltage	$I_{SD}=30A, V_{GS}=0V$		0.85	1.3	V
Dynamic^b						
Q_g	Total Gate Charge	$V_{DS}=15V, I_{DS}=80A$		28	32	nC
Q_{gs}	Gate-Source Charge	$V_{GS}=5V,$		12.8		
Q_{gd}	Gate-Drain Charge			21.2		
$t_{d(ON)}$	Turn-on Delay Time			13	20	ns
T_r	Turn-on Rise Time	$V_{DD}=15V, I_{DS}=1A,$		9	15	
$t_{d(OFF)}$	Turn-off Delay Time	$V_{GEN}=10V, R_G=0.2\Omega$		43	66	
T_f	Turn-off Fall Time			14	28	
C_{iss}	Input Capacitance	$V_{GS}=0V$		4700		pF
C_{oss}	Output Capacitance	$V_{DS}=15V$		930		
C_{rss}	Reverse Transfer Capacitance	Frequency=1.0MHz		280		

Notes

^a : Pulse test ; pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$

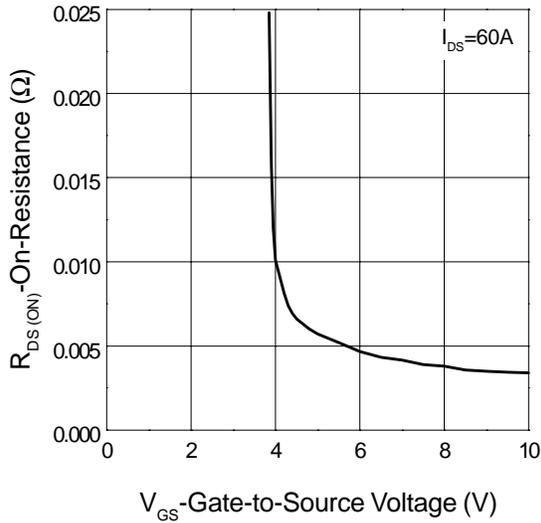
^b : Guaranteed by design, not subject to production testing

Typical Characteristics

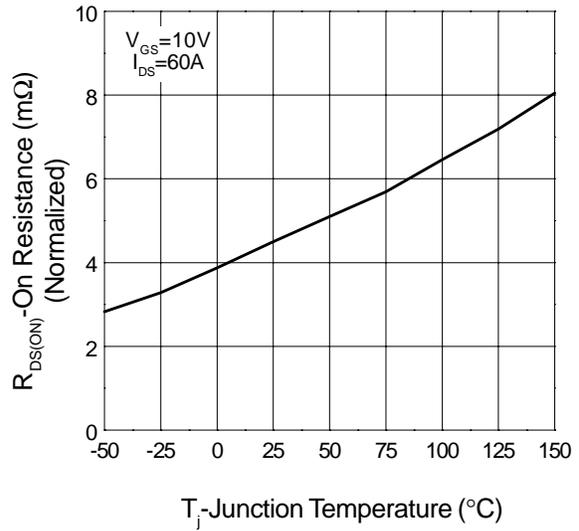


Typical Characteristics (Cont.)

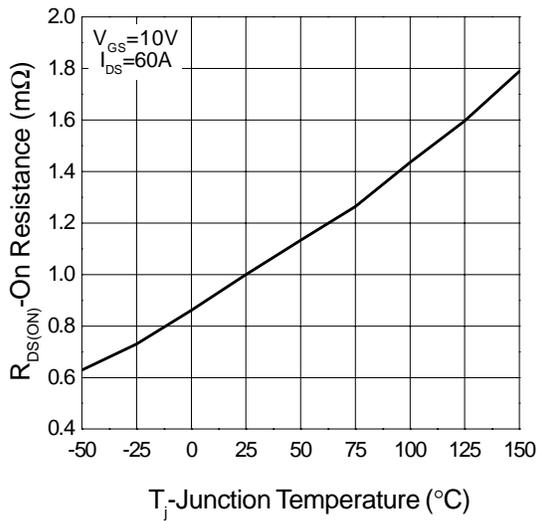
On-Resistance vs. Gate-to-Source Voltage



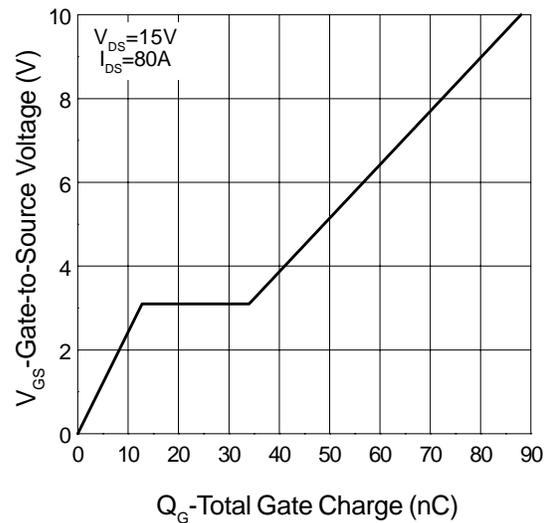
On-Resistance vs. Junction Temperature



On-Resistance vs. Junction Temperature

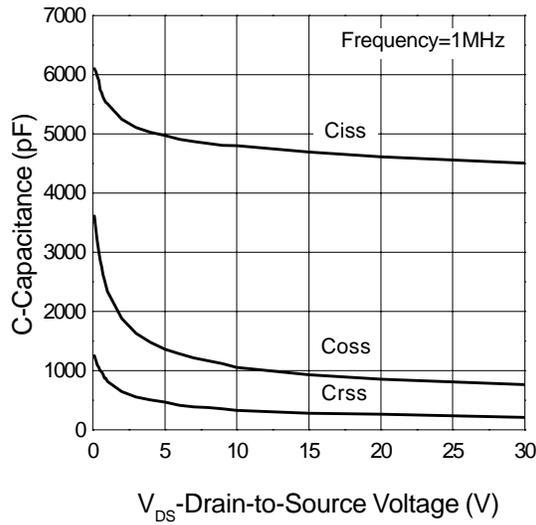


Gate Charge

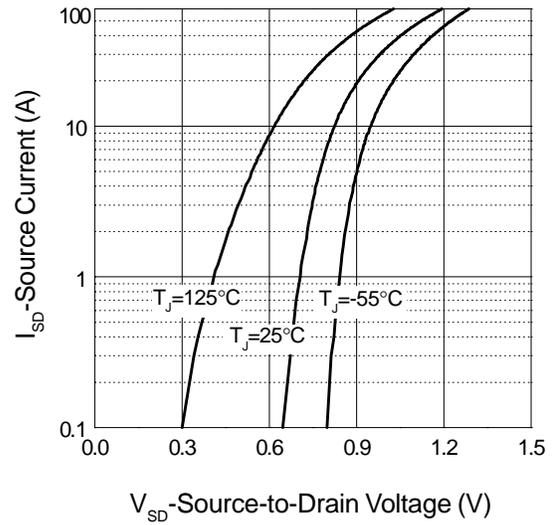


Typical Characteristics (Cont.)

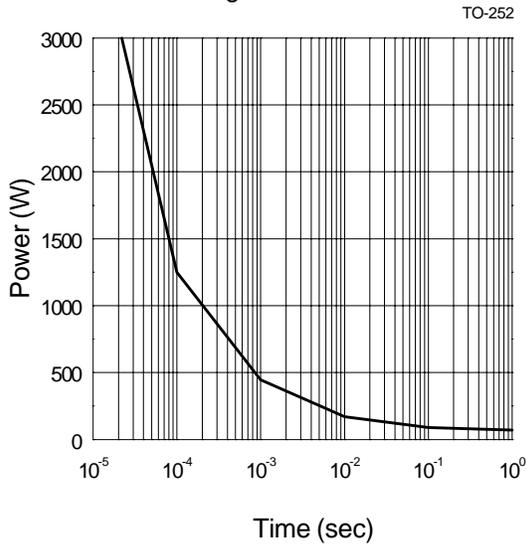
Capacitance Characteristics



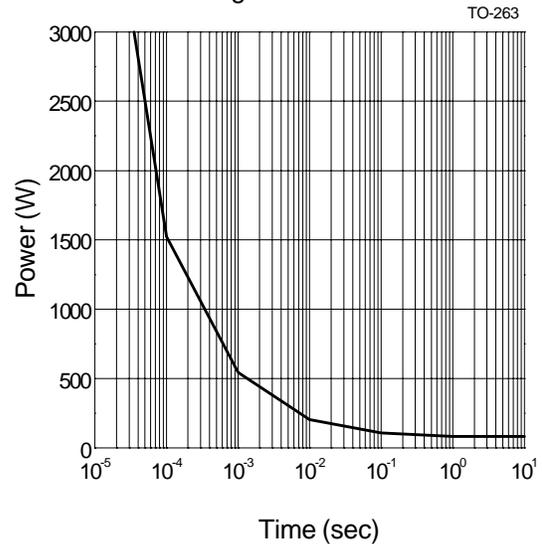
Source-Drain Diode Forward Voltage



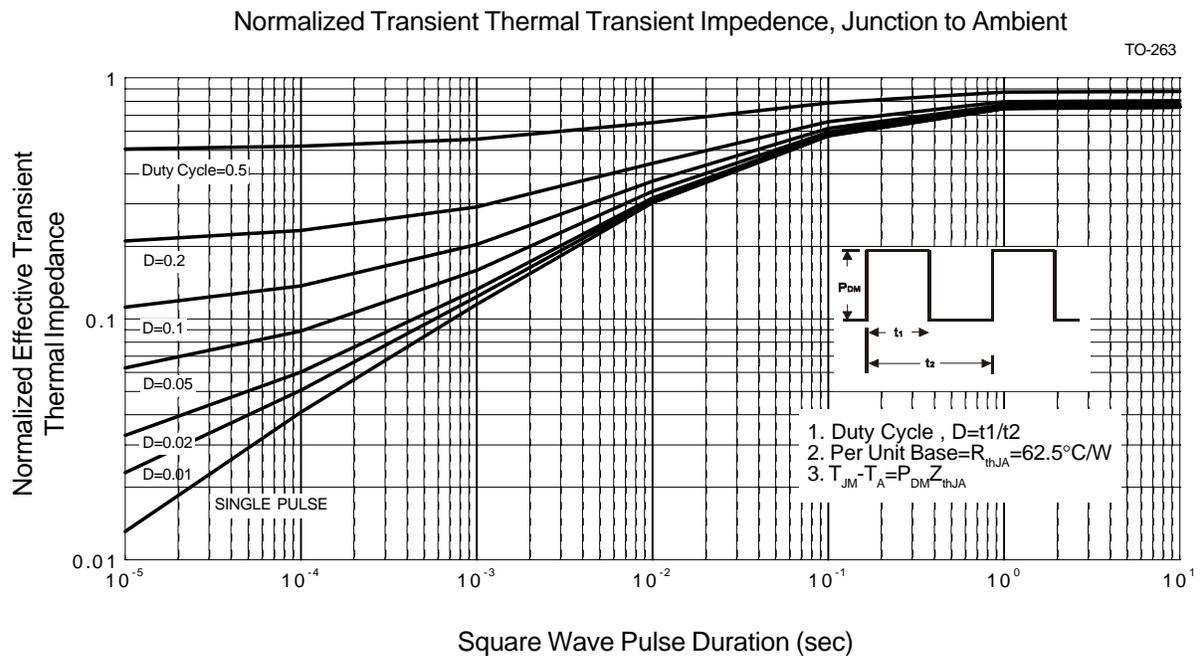
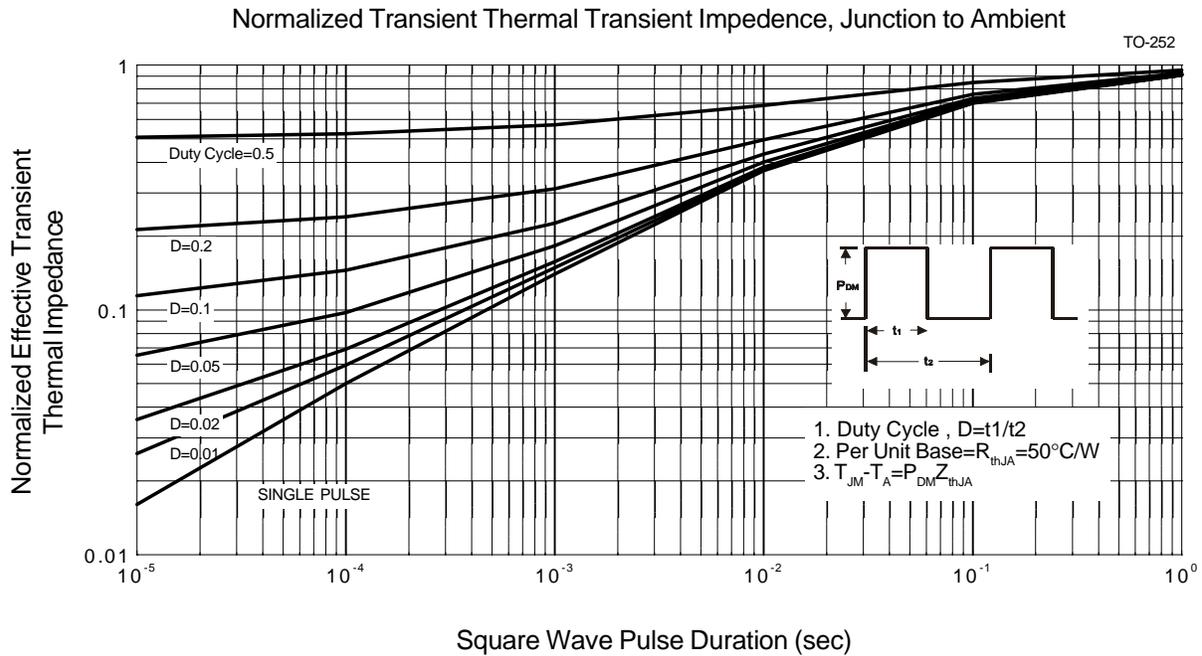
Single Pulse Power TO-252



Single Pulse Power TO-263

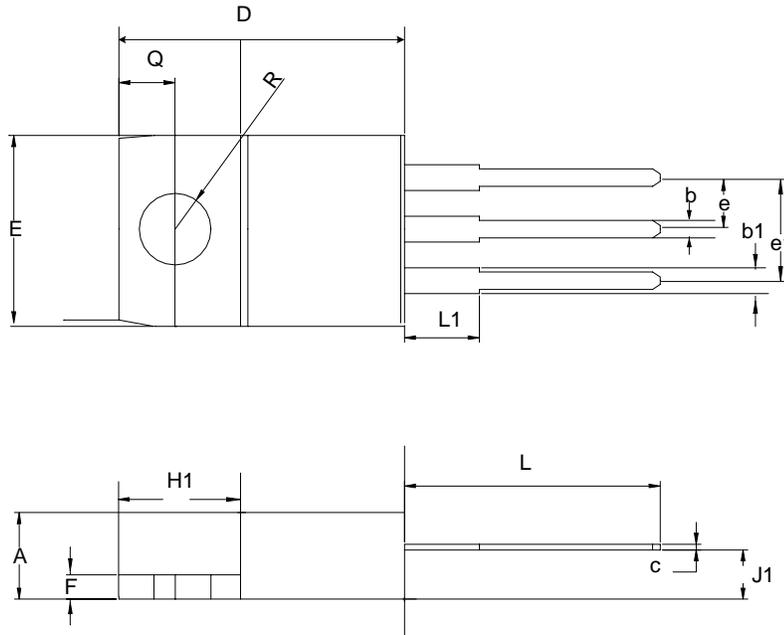


Typical Characteristics (Cont.)



Package Information

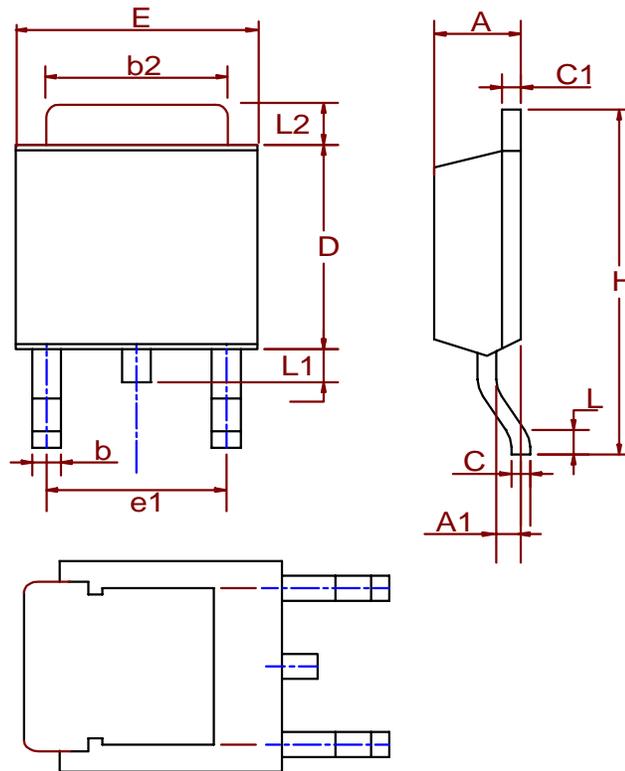
TO-220 (Reference JEDEC Registration TO-220)



Dim	Millimeters		Inches	
	Min.	Max.	Min.	Max.
A	3.56	4.83	0.140	0.190
b1	1.14	1.78	0.045	0.070
b	0.51	1.14	0.020	0.045
c	0.31	1.14	0.012	0.045
D	14.23	16.51	0.560	0.650
e	2.29	2.79	0.090	0.110
e1	4.83	5.33	0.190	0.210
E	9.65	10.67	0.380	0.420
F	0.51	1.40	0.020	0.055
H1	5.84	6.86	0.230	0.270
J1	2.03	2.92	0.080	0.115
L	12.7	14.73	0.500	0.580
L1	3.65	6.35	0.143	0.250
R	3.53	4.09	0.139	0.161
Q	2.54	3.43	0.100	0.135

Package Information (Cont.)

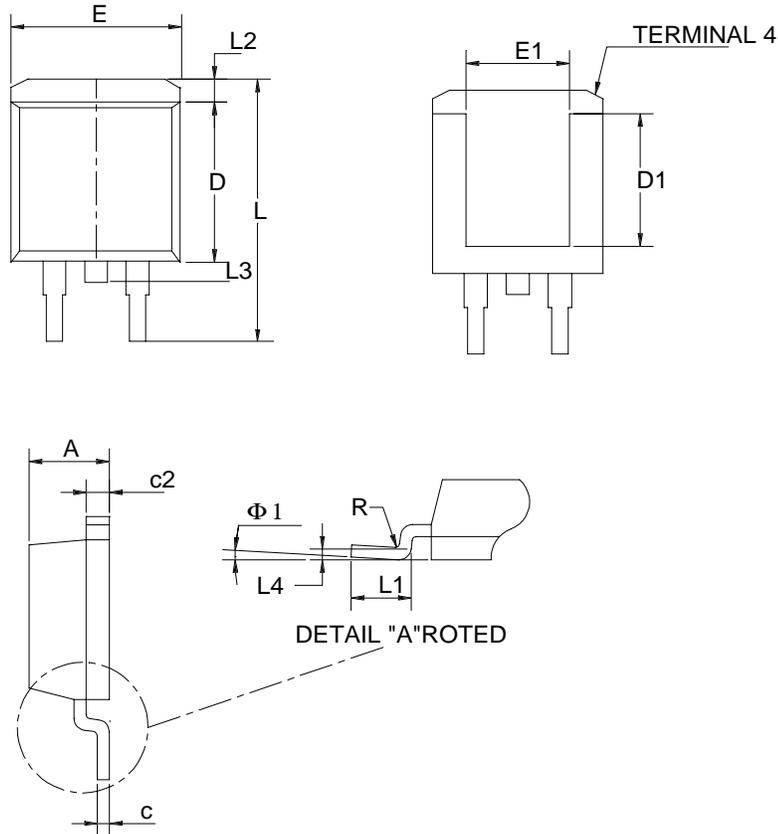
TO-252(Reference JEDEC Registration TO-252)



Dim	Millimeters		Inches	
	Min.	Max.	Min.	Max.
A	2.18	2.39	0.086	0.094
A1	0.89	1.27	0.035	0.050
b	0.508	0.89	0.020	0.035
b2	5.207	5.461	0.205	0.215
C	0.46	0.58	0.018	0.023
C1	0.46	0.58	0.018	0.023
D	5.334	6.22	0.210	0.245
E	6.35	6.73	0.250	0.265
e1	3.96	5.18	0.156	0.204
H	9.398	10.41	0.370	0.410
L	0.51		0.020	
L1	0.64	1.02	0.025	0.040
L2	0.89	2.032	0.035	0.080

Package Information (Cont.)

TO-263 (Reference JEDEC Registration TO-263)



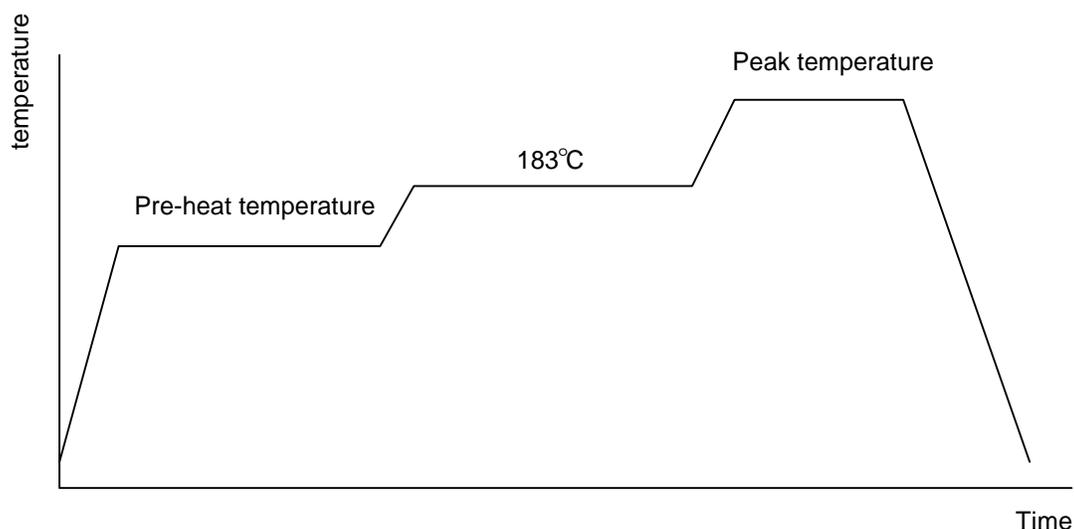
Dim	Millimeters		Inches	
	Min.	Max.	Min.	Max.
A	4.06	4.83	0.160	0.190
b	0.51	1.016	0.02	0.040
b2	1.14	1.651	0.045	0.065
c	0.38 TYP.		0.015 TYP.	
c2	1.14	1.40	0.045	0.055
D	8.64	9.65	0.340	0.380
E	9.65	10.54	0.380	0.415
L	14.60	15.88	0.575	0.625
L1	2.24	2.84	0.090	0.110
L2	1.02	2.92	0.040	0.112
L3	1.20	1.78	0.050	0.070

Physical Specifications

Terminal Material	Solder-Plated Copper (Solder Material : 90/10 or 63/37 SnPb)
Lead Solderability	Meets EIA Specification RS186-91, ANSI/J-STD-002 Category 3.

Reflow Condition (IR/Convection or VPR Reflow)

Reference JEDEC Standard J-STD-020A APRIL 1999



Classification Reflow Profiles

	Convection or IR/ Convection	VPR
Average ramp-up rate(183 °C to Peak)	3 °C/second max.	10 °C /second max.
Preheat temperature 125 ± 25 °C)	120 seconds max.	
Temperature maintained above 183 °C	60 ~ 150 seconds	
Time within 5 °C of actual peak temperature	10 ~ 20 seconds	60 seconds
Peak temperature range	220 +5/-0 °C or 235 +5/-0 °C	215~ 219 °C or 235 +5/-0 °C
Ramp-down rate	6 °C /second max.	10 °C /second max.
Time 25 °C to peak temperature	6 minutes max.	

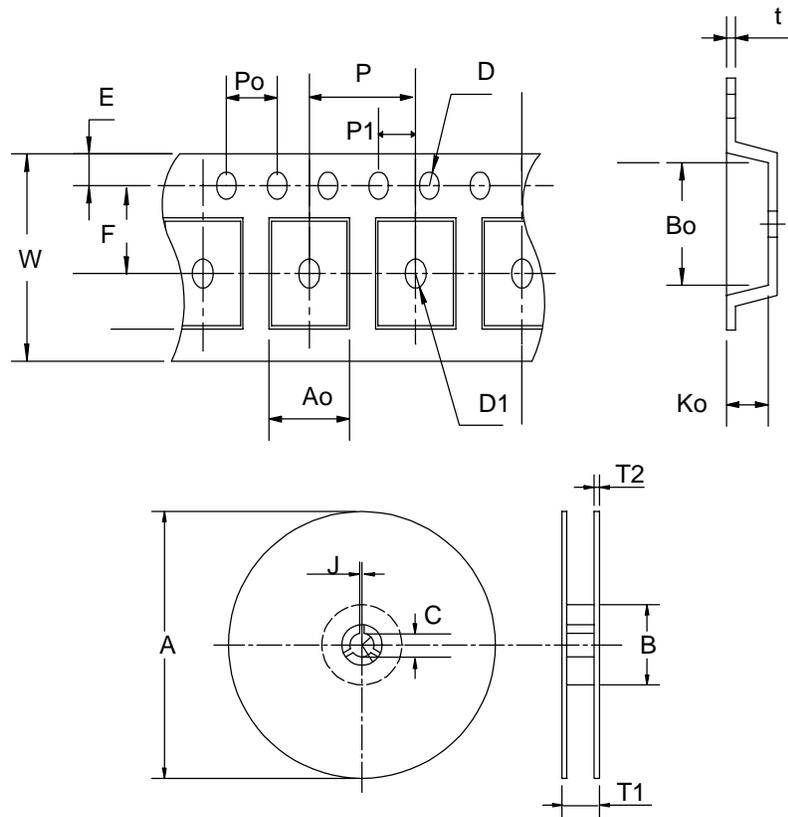
Package Reflow Conditions

pkg. thickness ≥ 2.5mm and all bags	pkg. thickness < 2.5mm and pkg. volume ≥ 350 mm	pkg. thickness < 2.5mm and pkg. volume <
Convection 220 +5/-0 °C		Convection 235 +5/-0 °C
VPR 215-219 °C		VPR 235 +5/-0 °C
IR/Convection 220 +5/-0 °C		IR/Convection 235 +5/-0 °C

Reliability test program

Test item	Method	Description
SOLDERABILITY	MIL-STD-883D-2003	245°C, 5 SEC
HOLT	MIL-STD 883D-1005.7	1000 Hrs Bias @ 125°C
PCT	JESD-22-B, A102	168 Hrs, 100% RH, 121°C
TST	MIL-STD 883D-1011.9	-65°C ~ 150°C, 200 Cycles

Carrier Tape & Reel Dimension



Application	A	B	C	J	T1	T2	W	P	E
TO-252	330 ± 3	100 ± 2	13 ± 0.5	2 ± 0.5	16.4 +0.3 -0.2	2.5 ± 0.5	16 +0.3 -0.1	8 ± 0.1	1.75 ± 0.1
	F	D	D1	Po	P1	Ao	Bo	Ko	t
	7.5 ± 0.1	1.5 +0.1	1.5 ± 0.25	4.0 ± 0.1	2.0 ± 0.1	6.8 ± 0.1	10.4 ± 0.1	2.5 ± 0.1	0.3 ± 0.05
Application	A	B	C	J	T1	T2	W	P	E
TO-263	380 ± 3	80 ± 2	13 ± 0.5	2 ± 0.5	24 ± 4	2 ± 0.3	24 +0.3 -0.1	16 ± 0.1	1.75 ± 0.1
	F	D	D1	Po	P1	Ao	Bo	Ko	t
	11.5 ± 0.1	1.5 +0.1	1.5 ± 0.25	4.0 ± 0.1	2.0 ± 0.1	10.8 ± 0.1	16.1 ± 0.1	5.2 ± 0.1	0.35 ± 0.013

Cover Tape Dimensions

Application	Carrier Width	Cover Tape Width	Devices Per Reel
TO- 252	16	13.3	2500
TO- 263	24	21.3	1000

Customer Service

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